Application/Control No. Applicant(s)/Patent Under Reexamination 10/612,649 YOON ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 Thoi V. Duong 2871 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0054269 05-2002 Α Maeda et al. 349/181 US-В US-С D US-Ε US-F US-G US-Н US-US-US-J Κ US-L US-US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S

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